

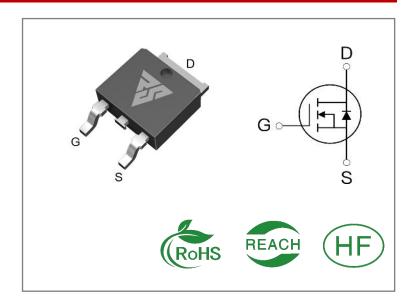
ID	R _{DS} (ON)(Typ)	VDSS
7A	1.1Ω	650V

Applications:

- Switch Mode Power Supply(SMPS)
- Adapter & Charger
- AC-DC Switching Power Supply

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Package Marking		Qty.	
RS7N65D	T0-252	RS7N65D	Tape&reel	2500 PCS	

Absolute Maximun Ratings Tc= 25℃ unless otherwise specified

Symbol	Parameter	RS7N65D	Units
VDSS	Drain-to-Source Voltage	650	V
ID	Continuous Drain Current TC=25℃	7	Δ
IDM	Pulsed Drain Current (Note*1)	28	Α
PD	Power Dissipation	110	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	165	mJ
	Maximum Temperature for Soldering	300	
TL TPKG	TL TPKG Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds		${\mathbb C}$
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS7N65D	Units	Test Conditions
RÐJC	Junction-to-Case	1.13	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}$ C
RθJA	Junction-to- Ambient	80		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25 ^oC unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	650			V	VGS=0V,ID=250μ A
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=650V,VGS= 0V
ICCC	Gate- to- Source Forward Leakage			100	- A	VGS=30V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		1.1	1.35	Ω	VGS=10V,ID=3.5 A
VGS(TH	Gate Threshold Voltage	3		4	٧	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		39			
trise	Rise Time		23			VDS=325V
td(OFF)	Turn- OFF Delay Time		137		nS	ID=7A RG=25Ω
tfall	Fall Time		60			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		891			VGS=0V
Coss	Output Capacitance		87		рF	VDS=25V
Crss	Reverse Transfer Capacitance		10			f=1.0MHz
Qg	Total Gate Charge		32			VDS=520V
Qgs	Gate- to- Source Charge		4.6		nC	ID=7A
Qgd	Gate-to-Drain(" Miller") Charge		14			VGS=10V

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			7	Α	Integral pn- diode
ISM	Maximum Pulsed Current			28	Α	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=3.5A,VGS=0V
trr	Reverse Recovery Time		891		nS	VGS=0V
Qrr	Reverse Recovery Charge	Recovery Charge 87 -			μС	IS=7A,di/dt=100A /μs

Notes:

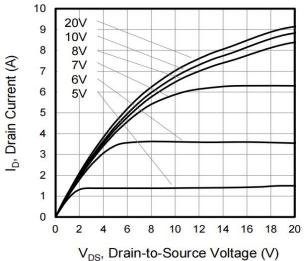
^{* 1.} Repetitive rating, pulse width limited by maximum junction temperature.

^{* 2.} Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%



Typical Feature Curve

Figure 1. Output Characteristics (T_J = 25°C)



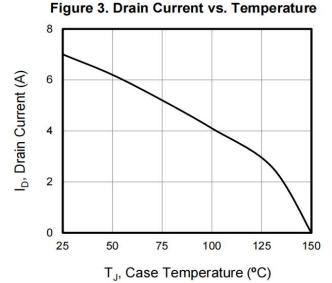


Figure 5. Transfer Characteristics

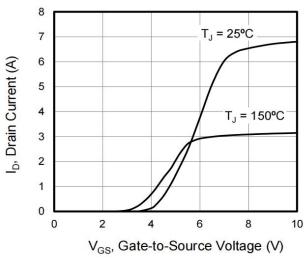


Figure 2. Body Diode Forward Voltage

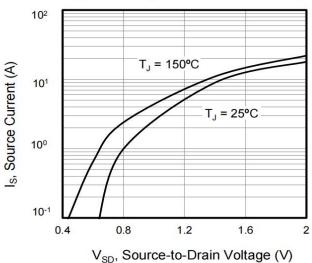


Figure 4. BV_{DSS} Variation vs. Temperature

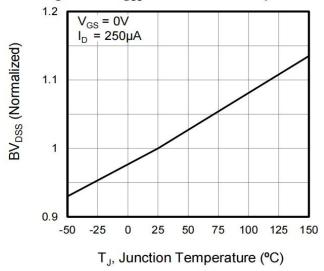
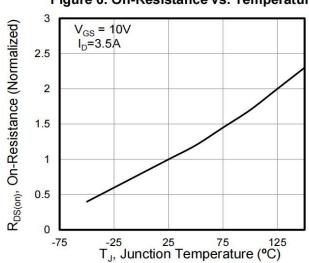


Figure 6. On-Resistance vs. Temperature





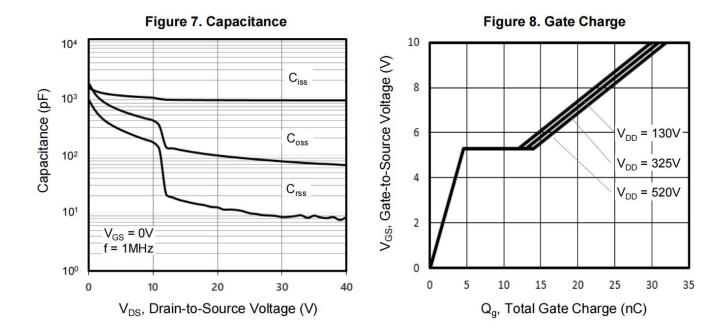
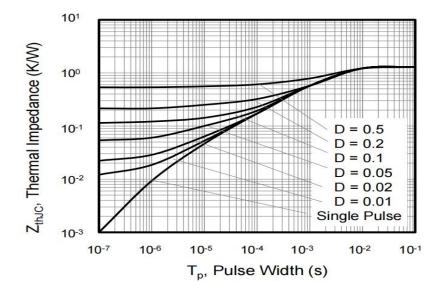


Figure 9. Transient Thermal Impedance





Test Circuits and Waveforms

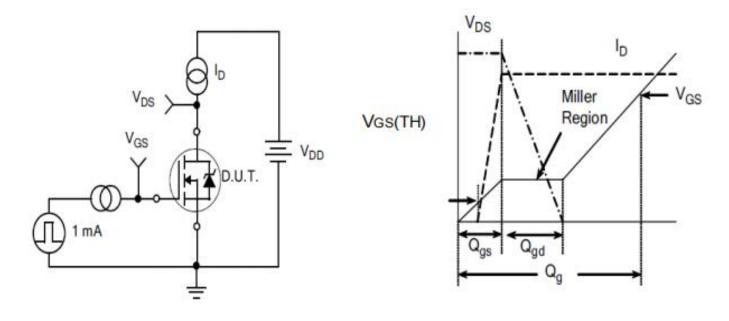


Figure 10.
Gate Charge Test Circuit

Figure11.
Gate Charge Waveform

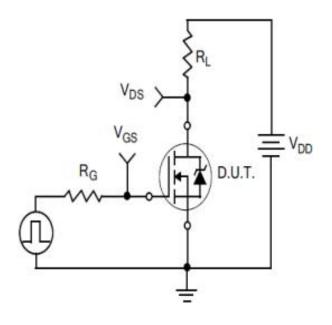


Figure12.
Resistive Switching Test Circuit

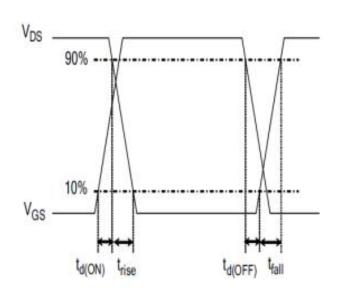


Figure 13.
Resistive Switching Waveforms



Test Circuits and Waveforms

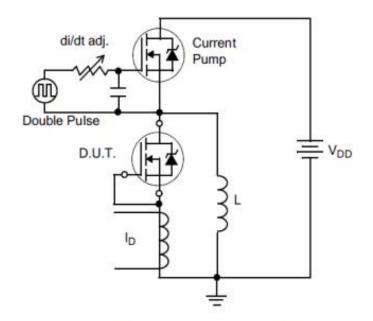


Figure 14. Diode Reverse Recovery
Test Circuit

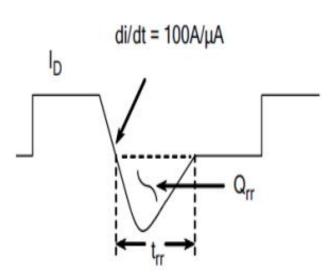


Figure 15. Diode Reverse Recovery Waveform

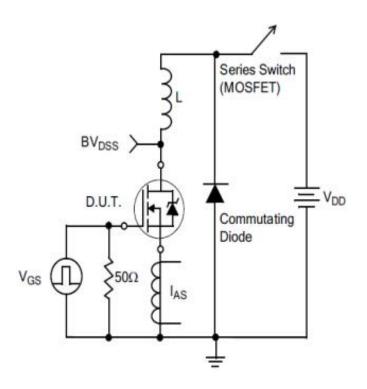
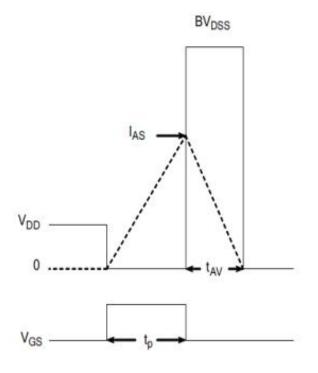


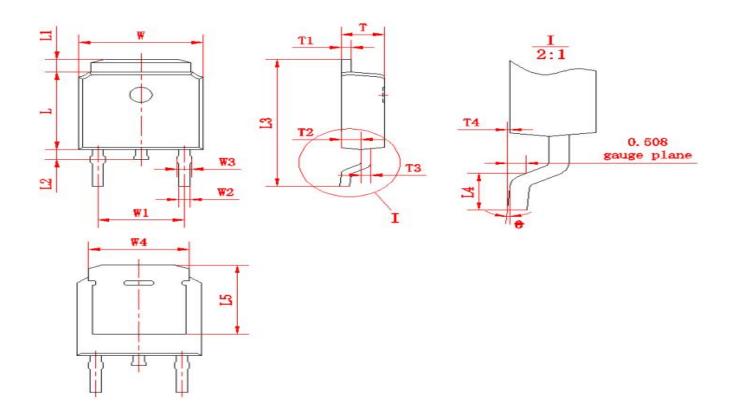
Figure 16. Unclamped Inductive Switching Test Circuit



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Package outline drawing(TO-252 Unit: mm)



符号	尺寸		符号	尺寸		符号	尺寸	
14.2	Min	Max	175	Min	Max	<u> </u>	Min	Max
W	6.50	6.70	L1	0.80	1.20	T1	0.48	0.58
W1	(4.572)		L2	0.60	1.00	T2	0.95	1.15
W2	0.6	0.8	L3	9.70	10.30	Т3	0.48	0.58
W3	0.68	0.88	L4	1.30	1.70	T4	0.00	0.12
W4	(5	.3)	L5	(5.20)		0	0	8
L	6.00	6.20	Т	2.20	2.40			



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